


Issue Classification 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/587,167	TANAKA ET AL.	
	Examiner	Art Unit	
	Patricia T. Nguyen	2817	

ISSUE CLASSIFICATION									
ORIGINAL				CROSS REFERENCE(S)					
CLASS		SUBCLASS		CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
330		129		330	124R	310			
INTERNATIONAL CLASSIFICATION									
H	0	3	G	3/20					
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----- (Assistant Examiner) (Date)		<i>Primary Examiner</i> <i>AU 2817</i> Patricia Nguyen 8/17/2007 <i>Patricia Nguyen</i> (Primary Examiner) (Date)	Total Claims Allowed: 20	
(Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. 1

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant					<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47		
Final	Original	Final	Original	Final	Original	Final	Original	Final	Original	Final	Original
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